

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

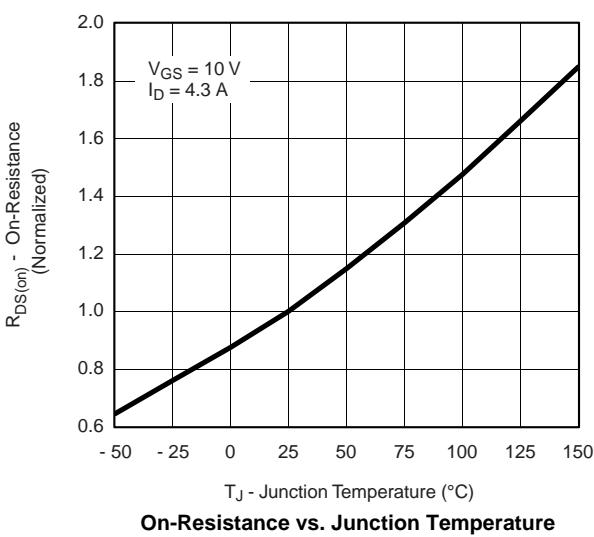
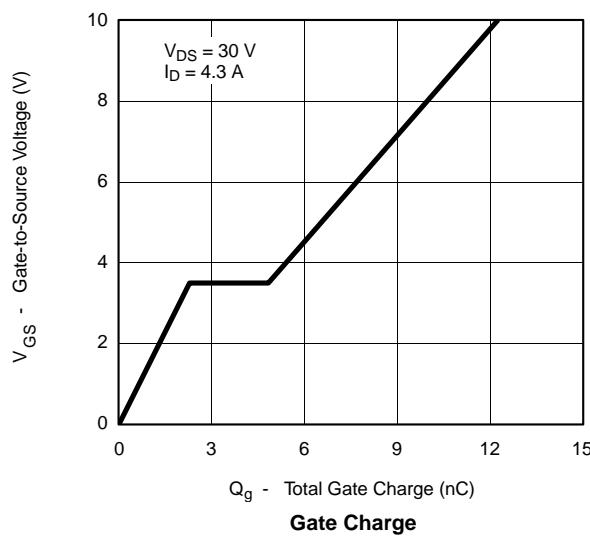
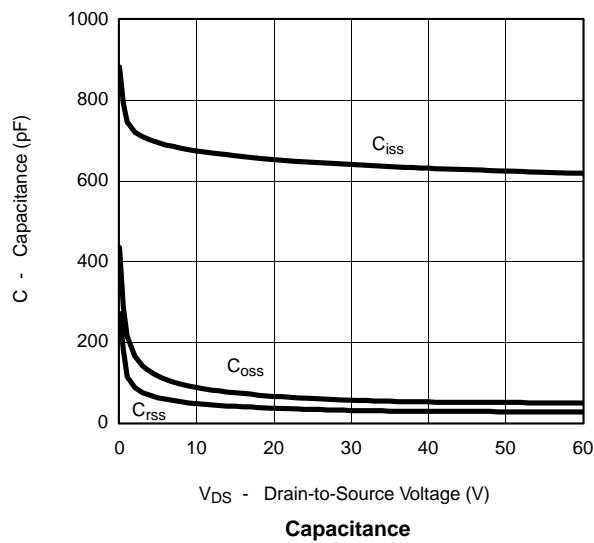
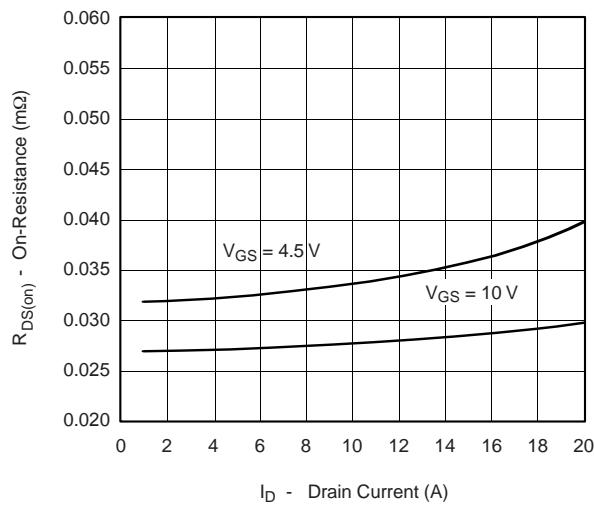
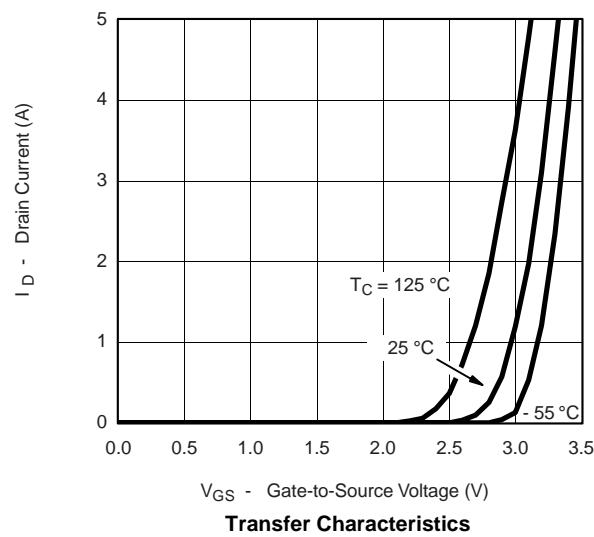
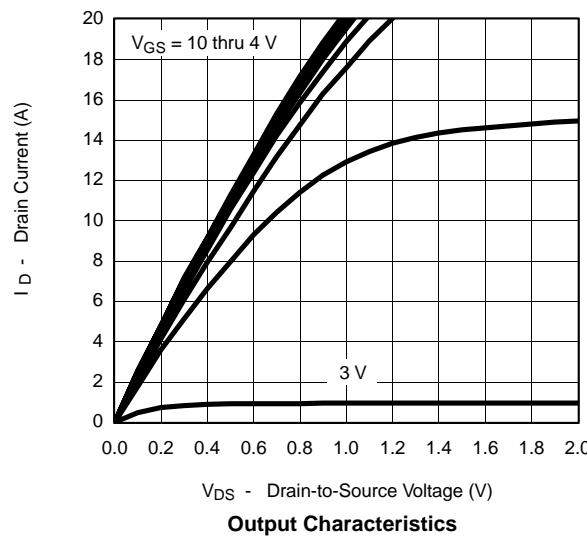
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit
Dynamic^a						
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 30 \text{ V}$, $R_L = 8.8 \Omega$ $I_D \geq 3.4 \text{ A}$, $V_{GEN} = 4.5 \text{ V}$, $R_g = 1 \Omega$	N-Ch	15	25	
Rise Time	t_r		P-Ch	30	45	
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -30 \text{ V}$, $R_L = 12.5 \Omega$ $I_D \leq -2.4 \text{ A}$, $V_{GEN} = -4.5 \text{ V}$, $R_g = 1 \Omega$	N-Ch	65	100	
Fall Time	t_f		P-Ch	70	105	
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 30 \text{ V}$, $R_L = 8.8 \Omega$ $I_D \geq 3.4 \text{ A}$, $V_{GEN} = 10 \text{ V}$, $R_g = 1 \Omega$	N-Ch	15	25	ns
Rise Time	t_r		P-Ch	40	60	
Turn-Off Delay Time	$t_{d(off)}$	P-Channel $V_{DD} = -30 \text{ V}$, $R_L = 12.5 \Omega$ $I_D \leq -2.4 \text{ A}$, $V_{GEN} = -10 \text{ V}$, $R_g = 1 \Omega$	N-Ch	10	15	
Fall Time	t_f		P-Ch	30	45	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$	N-Ch		2.6	
			P-Ch		-2.8	A
Pulse Diode Forward Current ^a	I_{SM}		N-Ch		20	
			P-Ch		-25	
Body Diode Voltage	V_{SD}	$I_S = 1.7 \text{ A}$	N-Ch	0.8	1.2	V
		$I_S = -2 \text{ A}$	P-Ch	-0.8	-1.2	
Body Diode Reverse Recovery Time	t_{rr}	N-Channel $I_F = 1.7 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	N-Ch	30	60	ns
Body Diode Reverse Recovery Charge	Q_{rr}		P-Ch	30	50	
Reverse Recovery Fall Time	t_a		N-Ch	32	50	nC
Reverse Recovery Rise Time	t_b		P-Ch	35	60	

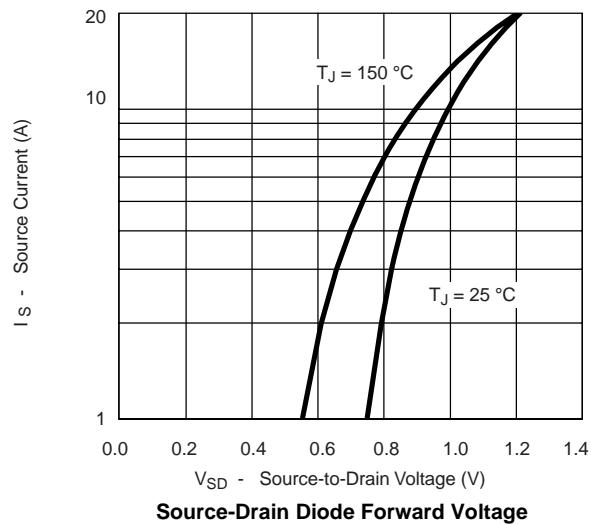
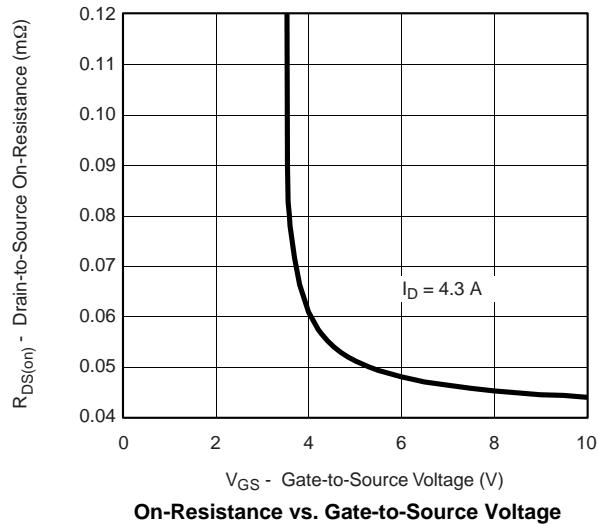
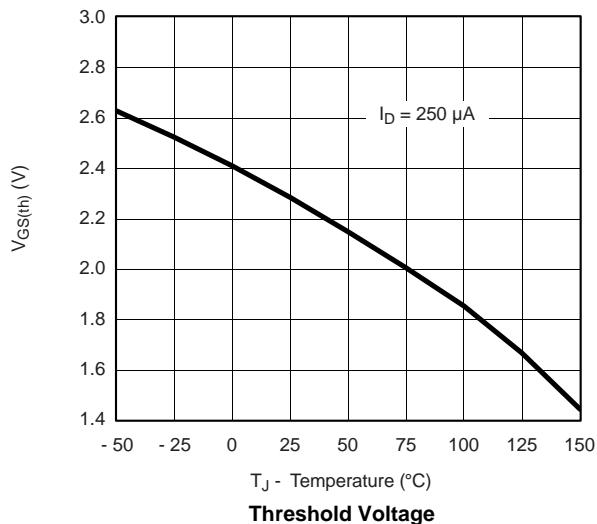
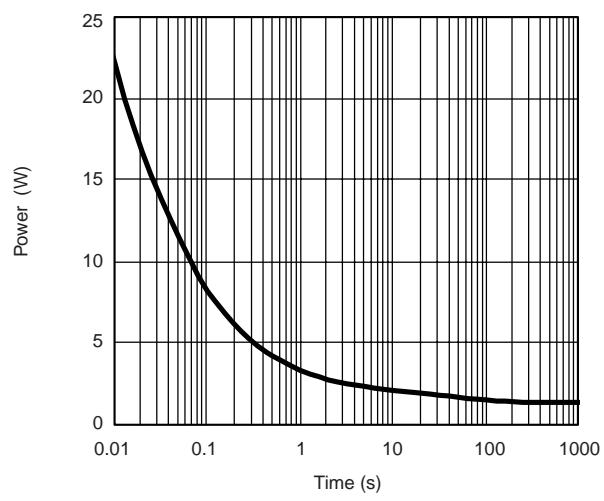
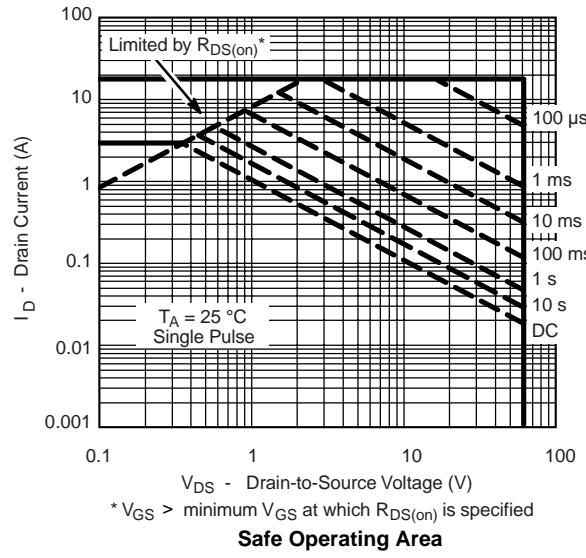
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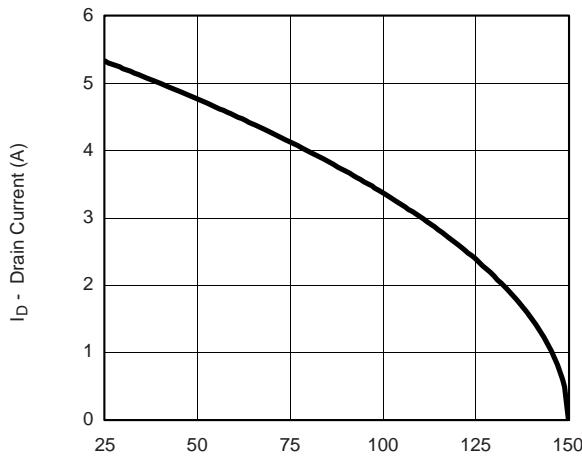
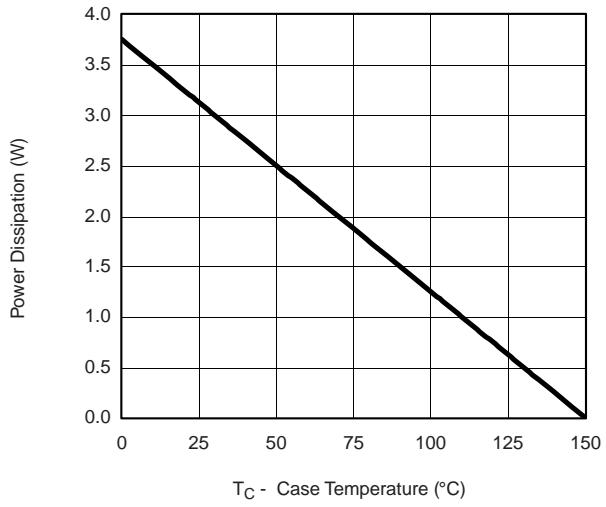
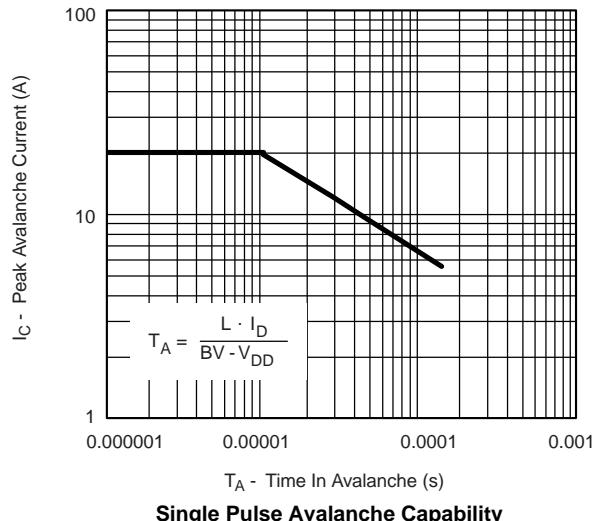
a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

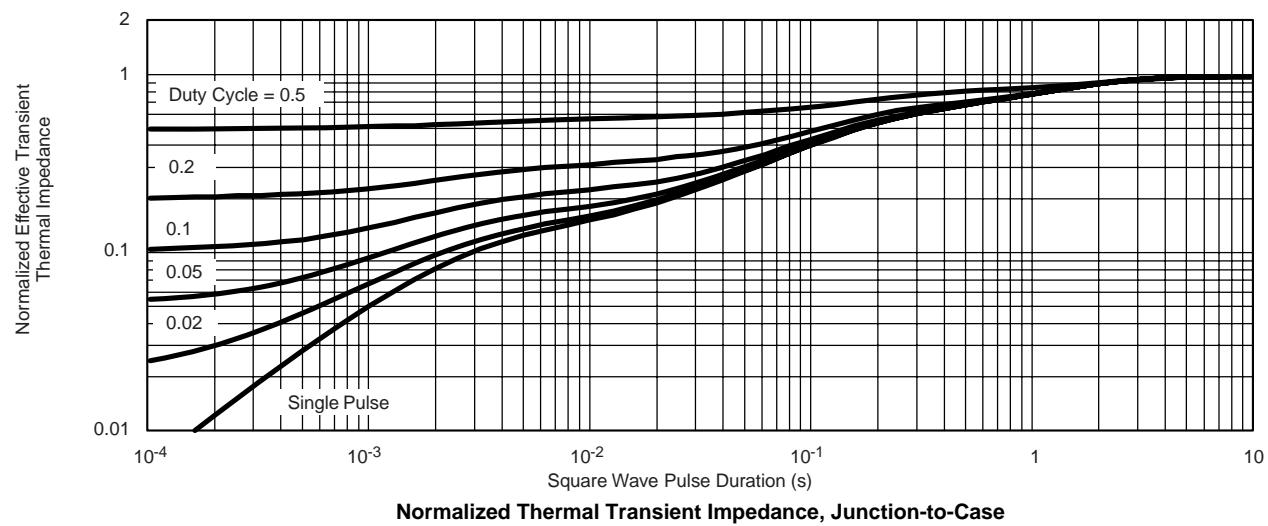
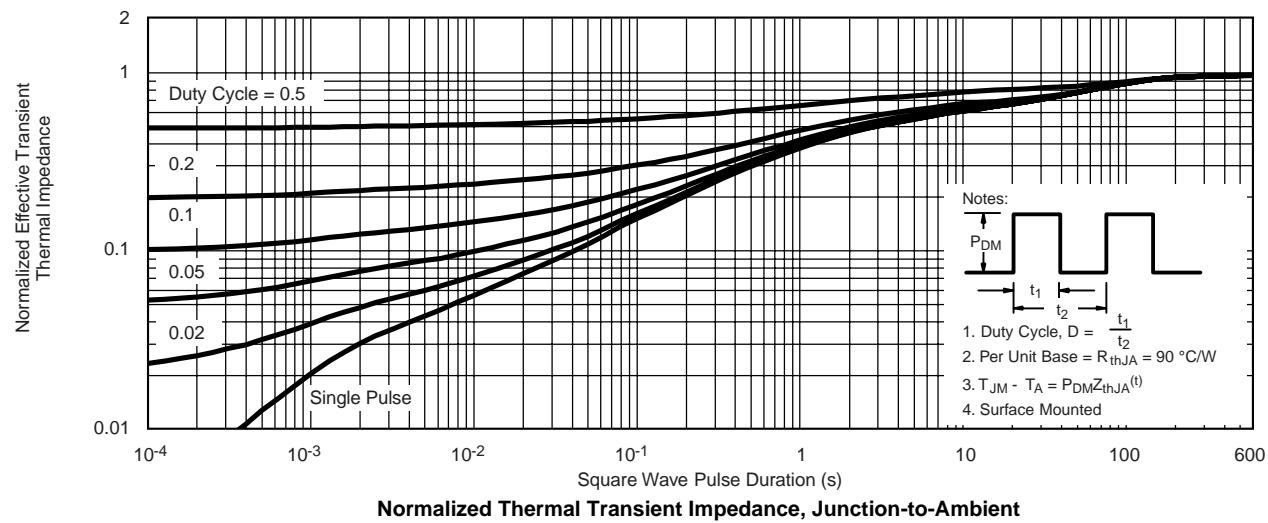
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

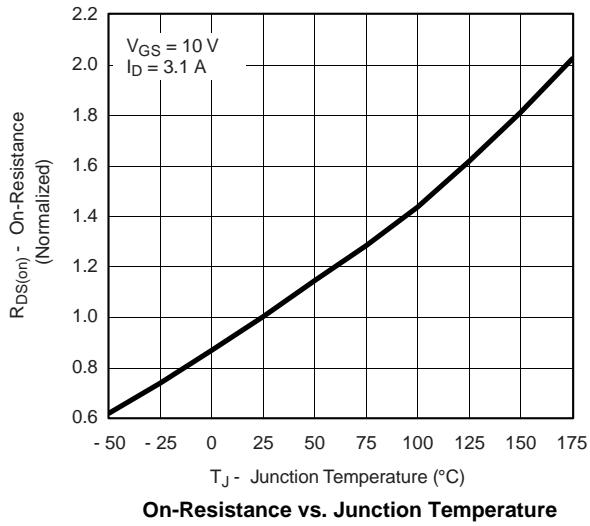
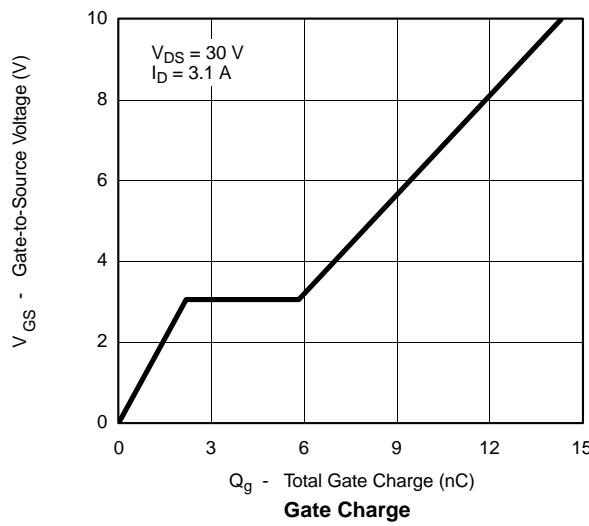
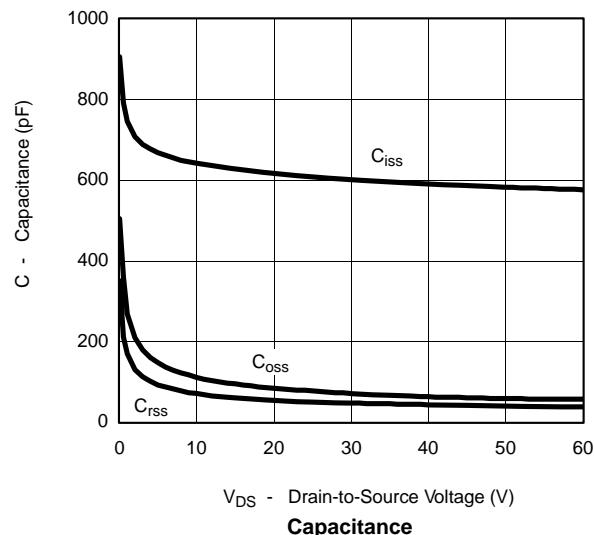
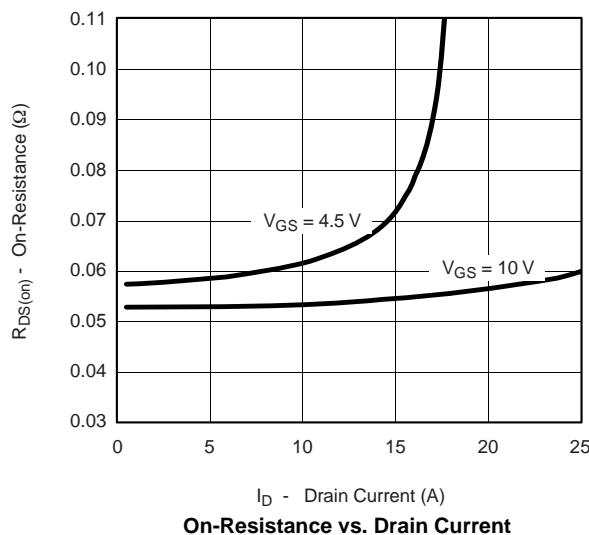
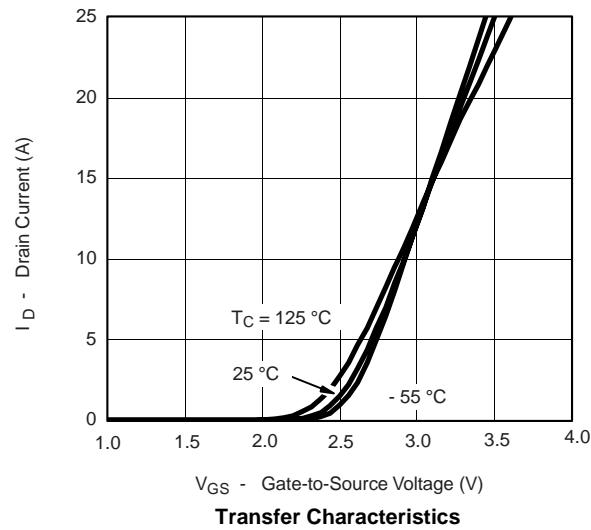
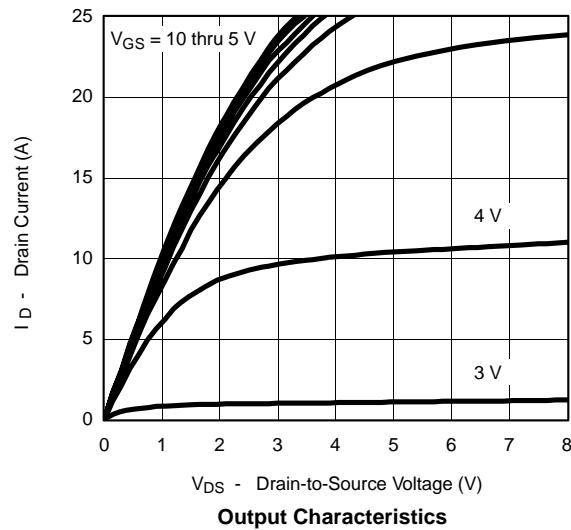
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

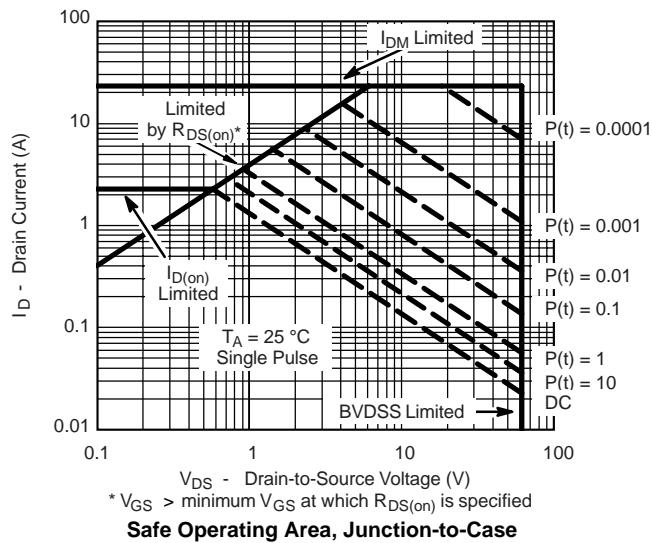
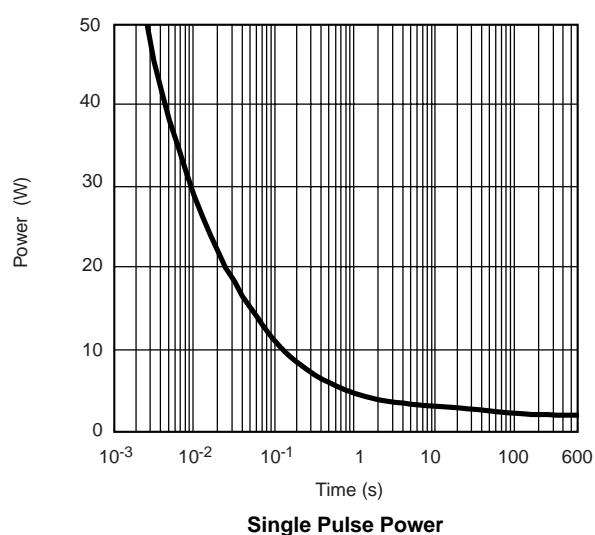
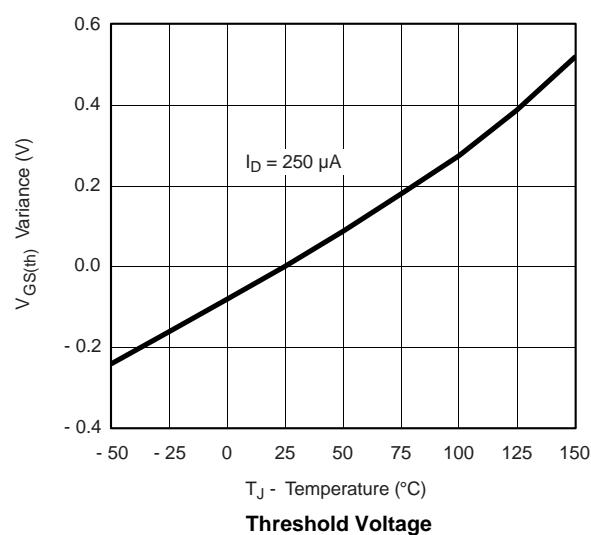
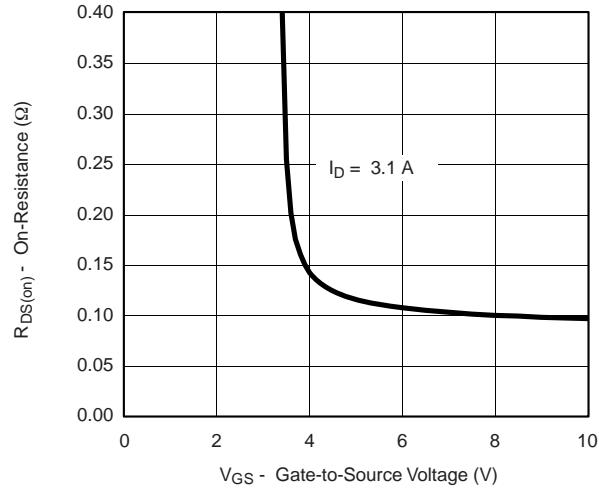
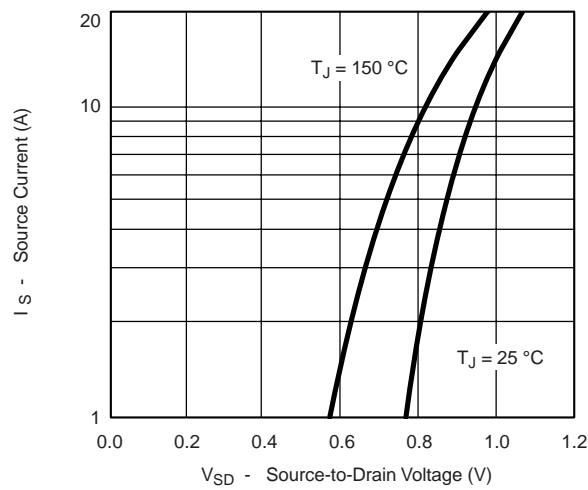
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted
**Source-Drain Diode Forward Voltage****On-Resistance vs. Gate-to-Source Voltage****Threshold Voltage****Single Pulse Power, Junction-to-Ambient****Safe Operating Area**

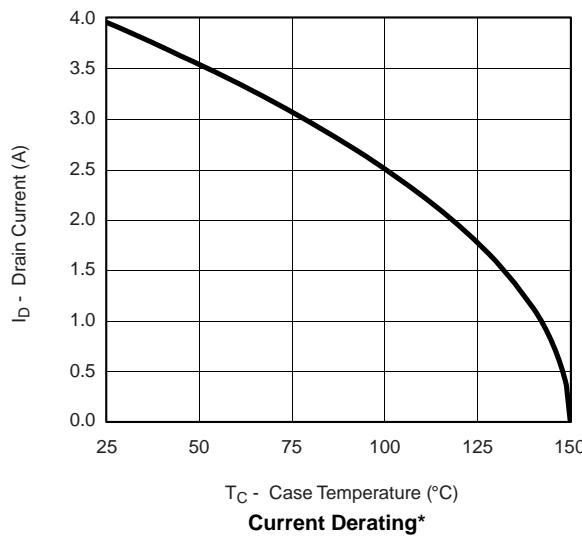
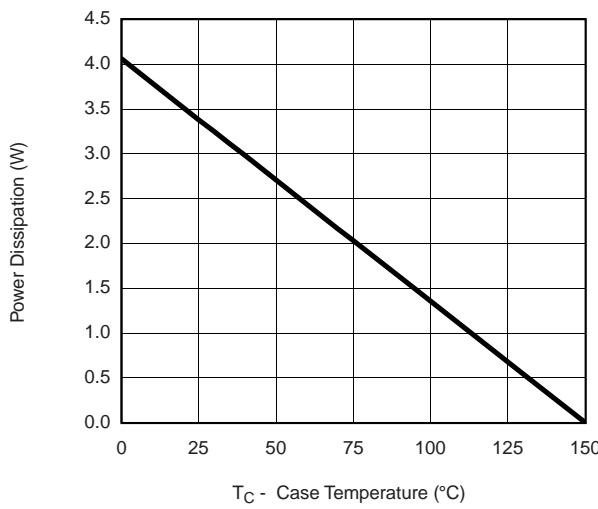
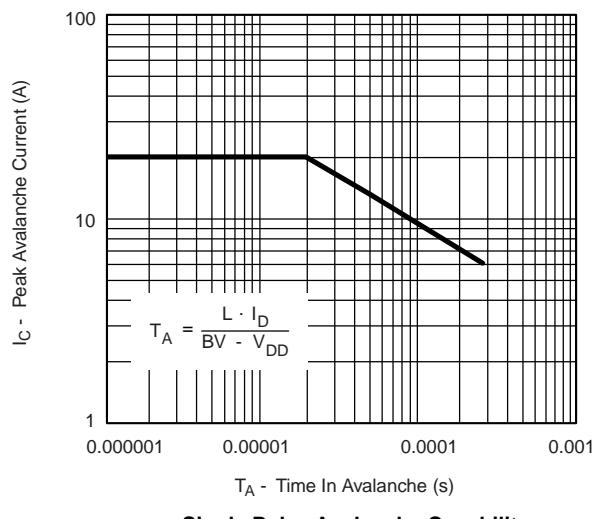
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted T_C - Case Temperature (°C)**Current Derating*** T_C - Case Temperature (°C)**Power Derating** T_A - Time In Avalanche (s)**Single Pulse Avalanche Capability**

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

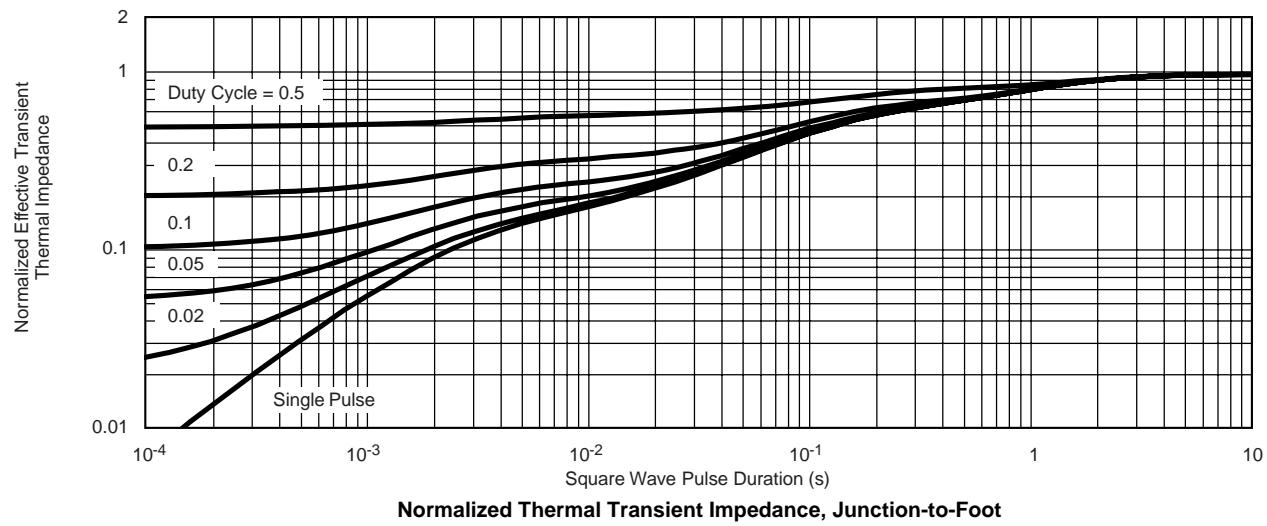
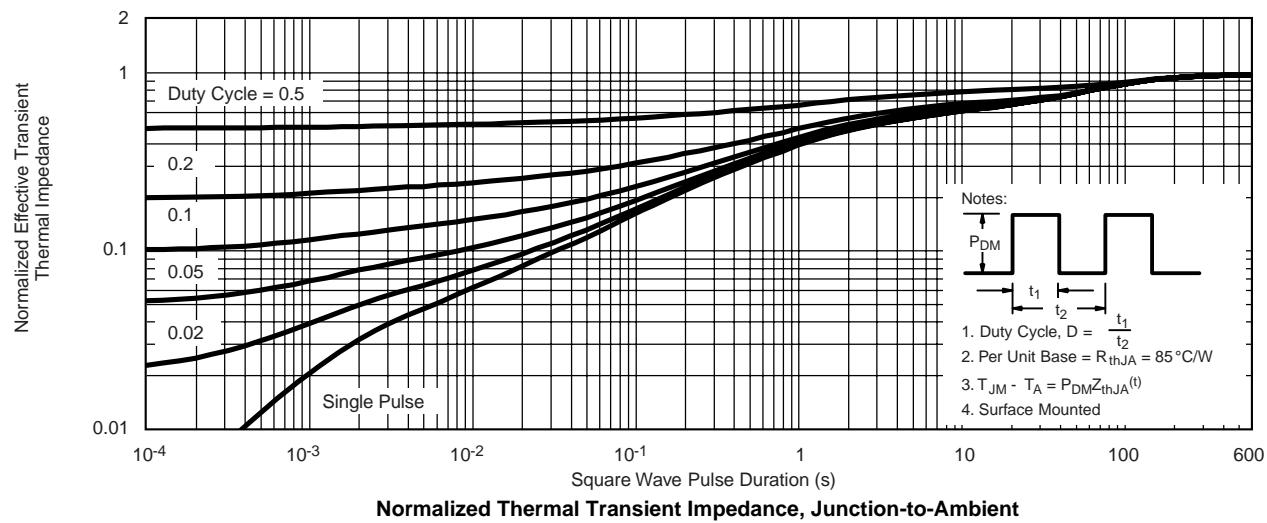
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


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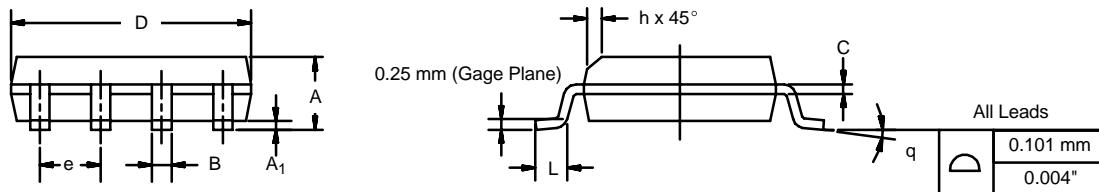
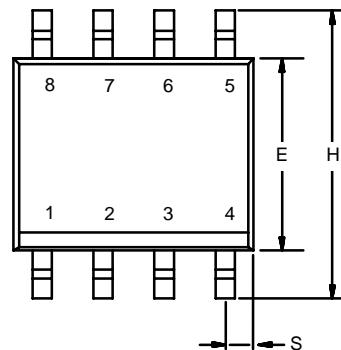
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted T_C - Case Temperature (°C)**Current Derating*** T_C - Case Temperature (°C)**Power Derating, Junction-to-Foot** T_A - Time In Avalanche (s)**Single Pulse Avalanche Capability**

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012



DIM	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	1.35	1.75	0.053	0.069
A ₁	0.10	0.20	0.004	0.008
B	0.35	0.51	0.014	0.020
C	0.19	0.25	0.0075	0.010
D	4.80	5.00	0.189	0.196
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.020
L	0.50	0.93	0.020	0.037
q	0°	8°	0°	8°
S	0.44	0.64	0.018	0.026

ECN: C-06527-Rev. I, 11-Sep-06
DWG: 5498

RECOMMENDED MINIMUM PADS FOR SO-8

